Precision Operational Amplifier, 10 μV, Zero-Drift, 1.6 V to 5.5 V Supply, 1.5 MHz

NCS21801, NCS21802, NCS21803, NCS21804

The NCS21801, NCS21802, NCS21803, and NCS21804 are precision op amps featuring low input offset voltage and low offset drift over time and temperature. The common mode voltage range extends 100 mV beyond the supply rails, which makes it suitable for both high-side and low-side current sensing applications.

The NCS2180x is available in single, dual, and quad channel configurations. All versions are specified for operation from -40° C to $+125^{\circ}$ C. NCV prefix parts are automotive grade 1 qualified and offer performance over the extended temperature range from -40° C to $+150^{\circ}$ C.

Features

- Input Offset Voltage: ±10 μV max
- Offset Voltage Drift Over Temperature: ±5 nV/°C Typical
- $\bullet~$ Common Mode Input Voltage Range: $V_{SS}-0.1~V$ to V_{DD} + 0.1~V
- Supply Voltage Range: 1.8 V to 5.5 V
- Extended Supply Voltage Range: 1.6 V to 5.5 V for $T_A = 0^{\circ}$ C to 85°C
- Unity Gain Bandwidth: 1.5 MHz
- Quiescent Consumption: 100 μA Max per Channel
- Enable Function Available on NCS21803
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- High-Side Current Sensing
- Low-Side Current Sensing
- Difference Amplifier
- Instrumentation Amplifier
- Power Management
- Automotive



ON Semiconductor®

www.onsemi.com



SC-88A / SC70-5 CASE 419A-02



TSOP-5 / SOT23-5 CASE 483



SC-88 / SC70-6 CASE 419B-02



UDFN8 CASE 517AW



Micro8
CASE 846A-02



TSSOP-14 WB CASE 948G

DEVICE MARKING INFORMATION

See general marking information in the device marking section on page 2 of this data sheet.

PIN CONNECTIONS

See pin connections on page 3 of this data sheet.

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

DEVICE MARKING INFORMATION



TSOP-5 / SOT23-5 CASE 483



SC-88A / SC70-5 CASE 419A-02



SC-88 / SC70-6 / SOT-363 CASE 419B-02



UDFN8, 2x2, 0.5P CASE 517AW



Micro8 CASE 846A-02



TSSOP-14 WB CASE 948G

XX = Specific Device Code A = Assembly Location

Y = Year
W = Work Week
M = Date Code
G or ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

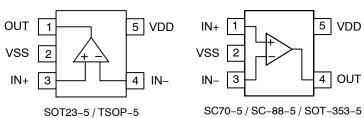
Channels	Enable	Package	Part Number	Marking	Shipping
INDUSTRIAL A	AND CONSUME	R			
Single	No	SOT23-5 / TSOP-5	NCS21801SN2T1G**		3000 / Tape & Reel
		SC70-5 / SC-88-5 / SOT-353-5	NCS21801SQ3T2G**		
	Yes	SC-88 / SC70-6 / SOT-363	NCS21803SQT2G**		1
Dual	No	UDFN-8	NCS21802MUTBG	AAJ	3000 / Tape & Reel
		Micro8	NCS21802DMR2G	802	4000 / Tape & Reel
Quad	No	TSSOP-14	NCS21804DTBR2G**		2500 / Tape & Reel
AUTOMOTIVE	QUALIFIED				
Single	No	SOT23-5 / TSOP-5	NCV21801SN2T1G**		3000 / Tape & Reel
		SC70-5 / SC-88-5 / SOT-353-5	NCV21801SQ3T2G**		1
Dual	No	Micro8	NCV21802DMR2G	802	4000 / Tape & Reel
Quad	No	TSSOP-14	NCV21804DTBR2G**		2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

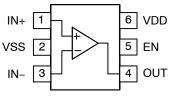
^{**} In development. Contact local sales office for more information.

PIN CONNECTIONS

Single Channel Configuration NCS21801

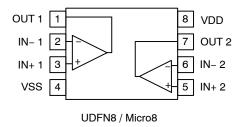


Single Channel with Enable Configuration NCS21803

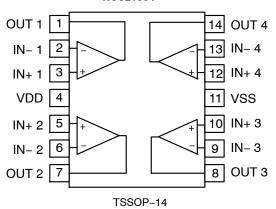


SC88 / SC70-6 / SOT-363

Dual Channel Configuration NCS21802



Quad Channel Configuration NCS21804



MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Rating	Unit
Supply Voltage (V _{DD} - V _{SS}) (Note 1)	V _S	-0.3 to 6	V
Input Voltage (Note 2)	$V_{IN+,}V_{IN-,}V_{EN}$	$(V_{SS} - 0.3)$ to $(V_{DD} + 0.3)$	V
Differential Input Voltage	$V_{\mathrm{IN+,}}V_{\mathrm{IN-}}$	$\pm (V_{DD} - V_{SS} + 0.3)$	V
Output Voltage (Note 2)	V _{OUT}	$(V_{SS} - 0.3)$ to $(V_{DD} + 0.3)$	V
Output Short Circuit Current (Note 3)	I _{OUT}	Continuous	
Input Current into Any Pin (Note 2)	I _{IN}	±10	mA
Maximum Junction Temperature	T _{J(max)}	+150	°C
Storage Temperature Range	T _{STG}	-65 to +150	°C
ESD Human Body Model (Note 4)	НВМ	±2000	٧
Charged Device Model (Note 4)	CDM	±1000	V
Latch-up Current (Note 5)		100	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for safe operating parameters
- 2. Terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.3 V beyond the supply rails should be current limited to ±10 mA or less. Output terminals should not be driven by external sources.
- 3. Short circuits to either rail can cause an increase in the junction temperature. The total power dissipation must be limited to prevent the junction temperature from exceeding the 150°C limit.
- 4. This device series incorporates ESD protection and is tested by the following methods: ESD Human Body Model tested per JEDEC standard JS-001-2017 (AEC-Q100-002) ESD Charged Device Model tested per JEDEC standard JS-002-2014 (AEC-Q100-011)
- 5. Latch-up Current tested per JEDEC standard: JESD78E.

THERMAL CHARACTERISTICS (Notes 6, 7)

Package	θ _{JA} Junction–to–Ambient Thermal Resistance	Ψ _{JT} Junction–to–Board Thermal Characteristic	Ψ _{JB} Junction–to–Case Top Thermal Characteristic	Unit
TSOP-5 / SOT23-5				
SC70-5 / SC-88-5 / SOT-353-5				
SC-88 / SC70-6 / SOT-363				0000
UDFN8	105	10	51	°C/W
Micro8 / MSOP-8	105	24	96	
TSSOP-14	86	9	53	

^{6.} Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for safe operating parameters

RECOMMENDED OPERATING RANGES

Parameter	Symbol	Conditions	Min	Max	Unit
Ambient Temperature	T _A	NCS prefix	-40	125	°C
		NCV prefix	-40	150 (Note 8)	
Common Mode Input Voltage	V _{CM}	Full temperature range	V _{SS} – 0.1	V _{DD} + 0.1	V
Supply Voltage (V _{DD} – V _{SS})	Vs	T _A = 0 to 85°C	1.6	5.5	V
		Full temperature range	1.8	5.5	

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

8. Operation up to T_A = 150°C is permitted, provided the total power dissipation is limited to prevent the junction temperature from exceeding the 150°C absolute maximum limit.

^{7.} Mounted on a JESD51-7 thermal board, 2S2P, 1 in² copper spreader area, 1 oz signal plane thickness

ELECTRICAL CHARACTERISTICS At $T_A = +25^{\circ}C$, $V_S = 1.8 \text{ V}$ to 5.5 V, and $V_{CM} = V_{OUT} = \text{mid-supply}$, unless otherwise noted. Boldface limits apply over the specified temperature range, unless otherwise noted, guaranteed by characterization and/or design.

Parameter	Symbol	Conditions	Temp (°C)	Min	Тур	Max	Unit
INPUT							
Input Offset Voltage	V _{OS}	V _S = 3.3 V	25		±2	±10	μV
Input Offset Voltage Drift vs.	dV _{OS} /dT	V _S = 1.8 V to 5.5 V	-40 to 125		±5	± 75	nV/°C
Temperature			-40 to 150		±5	± 75	
Common Mode Rejection Ratio	CMRR	V _S = 1.8 V,	25	106	131		dB
		$V_{CM} = V_{SS} - 0.1 \text{ V to } V_{DD} + 0.1 \text{ V}$	-40 to 125	100			
			-40 to 150	100			
		V _S = 3.3 V,	25	113	134		
		$V_{CM} = V_{SS} - 0.1 \text{ V to } V_{DD} + 0.1 \text{ V}$	-40 to 125	110			
			-40 to 150	110			
		V _S = 5.5 V,	25	111	137		
		$V_{CM} = V_{SS} - 0.1 \text{ V to } V_{DD} + 0.1 \text{ V}$	-40 to 125	108			
			-40 to 150	108			
Input Bias Current (Note 9)	I _{IB}		25		±60	±200	pА
			-40 to 125			±600	
			-40 to 150			±5000	
Input Offset Current	I _{OS}		25		±60	±300	pА
(Note 9)			-40 to 125			±400	
			-40 to 150			±2500	
Input Capacitance	C _{IN}	Differential	25		5		pF
		Common mode	25		5		
ENABLE (Note 10)							
Input Voltage Low Threshold	V _{EN-L}	Shutdown	-40 to 125			V _{SS} + 0.5	V
Input Voltage High Threshold	V _{EN-H}	Enabled	-40 to 125	V _{SS} + 1.3			V
Input Leakage Current	I _{EN}		25		1	100	nA
OUTPUT CHARACTERISTICS	•		•				
Open Loop Voltage Gain	A _{VOL}	V _S = 1.8 V	25	108	133		dB
			-40 to 125	106			
			-40 to 150	106			
		V _S = 3.3 V, 5.5 V	25	120	143		
			-40 to 125	110			
			-40 to 150	110			

^{9.} Guaranteed by characterization and/or design.

^{10.} The enable function is available on NCS21803 only. The EN pin must be connected to a logic low or logic high voltage.

11. Shutdown Time (t_{OFF}) and Enable Time (t_{ON}) are defined as the time between the 50% point of the signal applied to the EN pin and the point at which the output voltage reaches within 10% of its final value.

ELECTRICAL CHARACTERISTICS At $T_A = +25^{\circ}C$, $V_S = 1.8 \text{ V}$ to 5.5 V, and $V_{CM} = V_{OUT} = \text{mid-supply}$, unless otherwise noted. Boldface limits apply over the specified temperature range, unless otherwise noted, guaranteed by characterization and/or design.

Parameter	Symbol	Conditions	Temp (°C)	Min	Тур	Max	Unit
OUTPUT CHARACTERISTICS	-		•				•
Output Voltage High,	V _{DD} –	I _{OUT} = 30 μA	25		1	5	mV
Referenced from VDD Supply Rail	V _{OH}		-40 to 125			10	1
			-40 to 150			10	1
		V _S = 3.3 V, I _{OUT} = 3 mA	25		55	100	1
			-40 to 125			125	1
			-40 to 150			125	1
Output Voltage Low,	V _{OL} -	I _{OUT} = 30 μA	25		1	5	mV
Referenced to Vss Supply Rail	V _{SS}		-40 to 125			10	
			-40 to 150			10	1
		V _S = 3.3 V, I _{OUT} = 3 mA	25		55	100	1
			-40 to 125			125	1
			-40 to 150			125	1
Output Current Sourcing	I _O	V _S = 1.8 V	25		24		mA
Capability		V _S = 3.3 V	25		29		1
		V _S = 5.5 V	25		32		1
Output Current Sinking	I _O	V _S = 1.8 V	25		28		1
Capability		V _S = 3.3 V	25		32		1
		V _S = 5.5 V	25		38		1
Capacitive Load Capability	C _L	$A_V = -1$, $V_{IN} = 100$ mVpp step $A_V = 1$, $V_{IN} = 100$ mVpp step	25		400 125		pF
DYNAMIC RESPONSE			•				•
Unity Gain Bandwidth	BW	C _L = 20 pF	25		1.5		MHz
Gain Margin	A _M	C _L = 20 pF	25		6		dB
Phase Margin	Φ_{M}	C _L = 20 pF	25		50		٥
Slew Rate	SR		25		0.7		V/μs
Settling Time	t _s	0.1%, A _V = 1	25		20		μs
Overload Recovery Time	t _{OR}	V _{IN} * GAIN > V _S	25		200		μs
Channel Separation		NCS21802, NCS21804, f = 10 kHz	25		90		dB
EMI Rejection Ratio	EMIRR		25		See Fig. 26		dB
NOISE		•					
Voltage Noise Density	e _N	V _S = 3.3, f _{in} = 1 kHz	25		42		nV/√Hz
Voltage Noise, Peak-to-Peak	e _{P-P}	f _{in} = 0.1 Hz to 10 Hz	25		400		nV_PP
Current Noise Density	i _N	f _{in} = 1 kHZ	25		445		fA/√Hz

Guaranteed by characterization and/or design.
 The enable function is available on NCS21803 only. The EN pin must be connected to a logic low or logic high voltage.
 Shutdown Time (t_{OFF}) and Enable Time (t_{ON}) are defined as the time between the 50% point of the signal applied to the EN pin and the point at which the output voltage reaches within 10% of its final value.

ELECTRICAL CHARACTERISTICS At $T_A = +25^{\circ}C$, $V_S = 1.8 \text{ V}$ to 5.5 V, and $V_{CM} = V_{OUT} = \text{mid}$ –supply, unless otherwise noted. **Boldface** limits apply over the specified temperature range, unless otherwise noted, guaranteed by characterization and/or design.

Parameter	Symbol	Conditions	Temp (°C)	Min	Тур	Max	Unit
POWER SUPPLY							
Quiescent Current	ΙQ	NCS21801, NCS2803,	25		75	105	μΑ
	no load	-40 to 125			130		
			-40 to 150			200	
		NCS21802, NCS21804, per channel, no load	25		75	100	μΑ
		per channel, no load	-40 to 125			125	
			-40 to 150			150	
Quiescent Current in Shutdown	I _{QSD}	I _{QSD} Per channel	25		TBD	300	nA
(Note 10)			-40 to 105			300	
Power Supply Rejection Ratio	PSRR	V _S = 1.8 V to 5.5 V	25	115	140		dB
			-40 to 125	110			
			-40 to 150	110			
Power Up Time			25		40		μs
Enable Time (Note 10, 11)	t _{ON}		25		40		μs
Shutdown Time (Note 10, 11)	t _{OFF}		25		TBD		μs

^{9.} Guaranteed by characterization and/or design.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{10.} The enable function is available on NCS21803 only. The EN pin must be connected to a logic low or logic high voltage.

^{11.} Shutdown Time (t_{OFF}) and Enable Time (t_{ON}) are defined as the time between the 50% point of the signal applied to the EN pin and the point at which the output voltage reaches within 10% of its final value.

ELECTRICAL CHARACTERISTICS At $T_A = +25^{\circ}C$, $V_S = 1.6$ V, and $V_{CM} = V_{OUT} = mid$ –supply, unless otherwise noted. **Boldface** limits apply over the specified temperature range, $T_A = 0^{\circ}C$ to 85°C, guaranteed by characterization and/or design.

Parameter	Symbol	Conditions	Temp (°C)	Min	Тур	Max	Unit
INPUT	<u> </u>			<u> </u>		<u> </u>	<u> </u>
Input Offset Voltage	V _{OS}		25		±3	±13	μV
Input Offset Voltage Drift vs.	dV _{OS} /dT		0 to 85		±5	±75	nV/°C
Temperature	4 7 05/41		0 10 00				110, 0
Common Mode Rejection Ratio	CMRR	$V_{CM} = V_{SS} - 0.1 \text{ V to } V_{DD} + 0.1 \text{ V}$	25	96	123		dB
			0 to 85	94			
Input Bias Current	I _{IB}		25		±30	±160	pА
(Note 12)			0 to 85			±250	
Input Offset Current	I _{OS}		25		±36	±200	pА
(Note 12)			0 to 85			±250	
Input Capacitance	C _{IN}	Differential	25		5		pF
		Common mode	25		5		
ENABLE (Note 14)	-				-		
Input Voltage Low Threshold	V _{EN-L}	Shutdown	0 to 85			V _{SS} + 0.5	V
Input Voltage High Threshold	V _{EN-H}	Enabled	0 to 85	V _{SS} + 1.3			V
Input Leakage Current	I _{EN}		25		1	100	nA
OUTPUT CHARACTERISTICS							
Open Loop Voltage Gain	A _{VOL}		25	106	128		dB
			0 to 85	104			
Output Voltage High, Referenced from V _{DD}	V _{DD} -	I _{OUT} = 30 μA	25		1	5	mV
Referenced from V _{DD} Supply Rail	V _{OH}		0 to 85			10	
		I _{OUT} = 3 mA	25		85	130	
			0 to 85			150	
Output Voltage Low,	V _{OL} -	I _{OUT} = 30 μA	25		1	5	mV
Referenced to V _{SS} Supply Rail	V _{SS}		0 to 85			10	
		I _{OUT} = 3 mA	25		75	130	
			0 to 85			150	
Output Current Sourcing Capability	Io		25		15		mA
Output Current Sinking Capability	Io		25		21		
Capacitive Load Capability	C _L	$A_V = -1$, $V_{IN} = 100$ mVpp step $A_V = 1$, $V_{IN} = 100$ mVpp step	25		400 125		pF
DYNAMIC RESPONSE		•					
Unity Gain Bandwidth	BW	C _L = 20 pF	25		1.4		MHz
Gain Margin	A _M	C _L = 20 pF	25		6		dB
Phase Margin	Φ_{M}	C _L = 20 pF	25		50		0
Slew Rate	SR		25		0.7		V/μs

^{12.} Guaranteed by design and/or characterization.

^{13.} The enable function is available on NCS21803 only. The EN pin must be connected to a logic low or logic high voltage.

14. Shutdown Time (t_{OFF}) and Enable Time (t_{ON}) are defined as the time between the 50% point of the signal applied to the EN pin and the point at which the output voltage reaches within 10% of its final value.

 $\begin{tabular}{l} \textbf{ELECTRICAL CHARACTERISTICS} At T_A = +25 ^{\circ}C, \ V_S = 1.6 \ V, \ and \ V_{CM} = V_{OUT} = mid-supply, \ unless otherwise noted. \end{tabular} \begin{tabular}{l} \textbf{Boldface} \\ \textbf{limits} \ apply \ over the specified temperature range, \ T_A = 0 ^{\circ}C \ to \ 85 ^{\circ}C, \ guaranteed \ by \ characterization \ and/or \ design. \end{tabular}$

Parameter	Symbol	Conditions	Temp (°C)	Min	Тур	Max	Unit
DYNAMIC RESPONSE							
Settling Time	t _s	0.1%, A _V = 1	25		20		μs
Overload Recovery Time	t _{OR}	V _{IN} * GAIN > V _S	25		200		μs
Channel Separation		NCS21802, NCS21804, f = 10 kHz	25		90		dB
EMI Rejection Ratio	EMIRR		25		See Fig. 26		dB
NOISE							
Voltage Noise Density	e _N	f _{in} = 1 kHz	25		53		nV/√Hz
Voltage Noise, Peak-to-Peak	e _{P-P}	f _{in} = 0.1 Hz to 10 Hz	25		400		nV_{PP}
Current Noise Density	i _N	f _{in} = 1 kHz	25		450		fA/√Hz
POWER SUPPLY							
Quiescent Current	ΙQ	NCS21801, NCS21803,	25		70	95	μΑ
		no load	0 to 85			110	
		NCS21802, NCS21804,	25		65	90	
		per channel, no load	0 to 85			105	1
Quiescent Current in	I _{QSD}	Per channel	25		TBD	300	nA
Shutdown (Note 13)			0 to 85			300	
Power Supply Rejection Ratio	PSRR	V _S = 1.6 V to 5.5 V	25	115	135		dB
			0 to 85	110			
Power Up Time			25		40		μs
Enable Time (Notes 13, 14)	t _{ON}		25		40		μs
Shutdown Time (Notes 13, 14)	t _{OFF}		25		TBD		μs

^{12.} Guaranteed by design and/or characterization.

^{13.} The enable function is available on NCS21803 only. The EN pin must be connected to a logic low or logic high voltage.

14. Shutdown Time (t_{OFF}) and Enable Time (t_{ON}) are defined as the time between the 50% point of the signal applied to the EN pin and the point at which the output voltage reaches within 10% of its final value.

TYPICAL CHARACTERISTICS

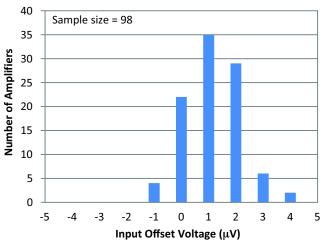


Figure 1. Input Offset Voltage Distribution with 3.3 V Supply

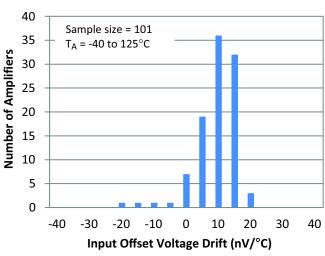


Figure 2. Input Offset Voltage Drift Distribution with 3.3 V Supply

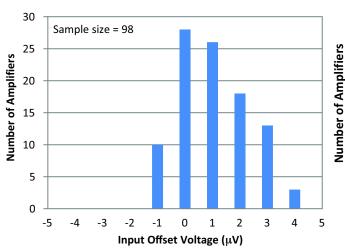


Figure 3. Input Offset Voltage Distribution with 1.6 V Supply

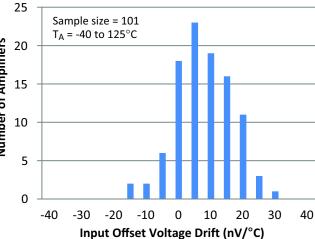


Figure 4. Input Offset Voltage Drift Distribution with 1.6 V Supply

TYPICAL CHARACTERISTICS

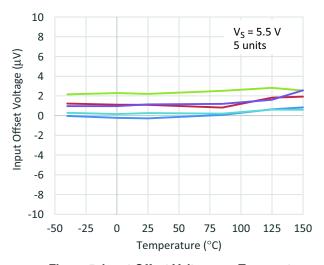


Figure 5. Input Offset Voltage vs. Temperature at 5.5 V Supply

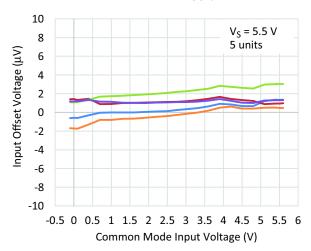


Figure 7. Input Offset Voltage vs. Common Mode Voltage at 5.5 V Supply

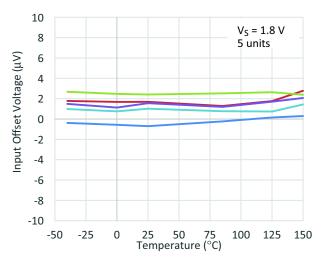


Figure 6. Input Offset Voltage vs. Temperature at 1.8 V Supply

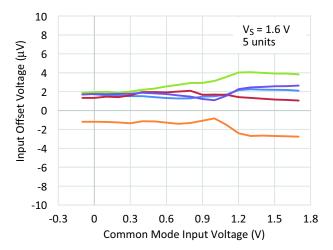


Figure 8. Input Offset Voltage vs. Common Mode Voltage at 1.6 V Supply

TYPICAL CHARACTERISTICS

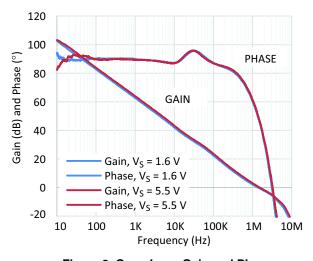


Figure 9. Open Loop Gain and Phase vs. Frequency

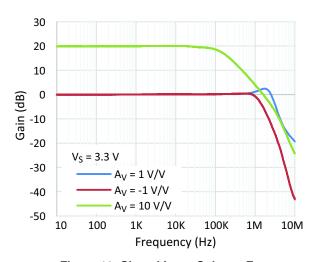


Figure 10. Closed Loop Gain vs. Frequency

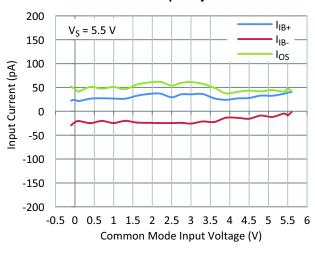


Figure 11. Input Bias Current and Input Offset Current vs. Common Mode Input Voltage

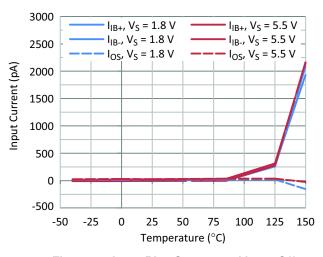


Figure 12. Input Bias Current and Input Offset Current vs. Temperature

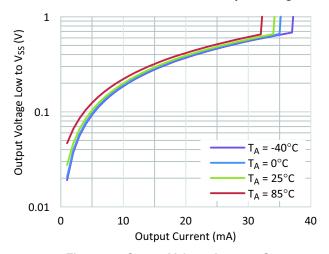


Figure 13. Output Voltage Low vs. Output Current at 5.5 V Supply

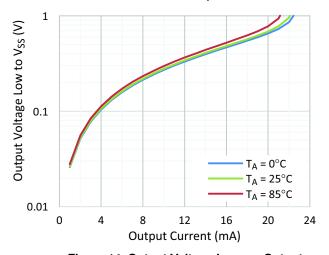


Figure 14. Output Voltage Low vs. Output Current at 1.6 V Supply

TYPICAL CHARACTERISTICS

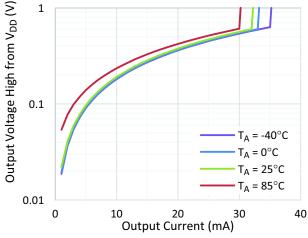


Figure 15. Output Voltage High vs. Output Current at 5.5 V Supply

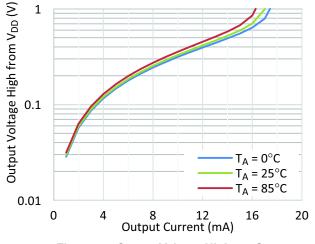


Figure 16. Output Voltage High vs. Output Current at 1.6 V Supply

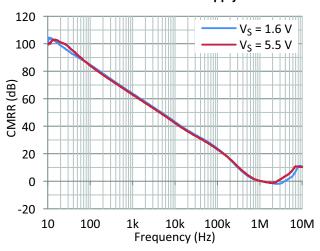


Figure 17. CMRR vs. Frequency

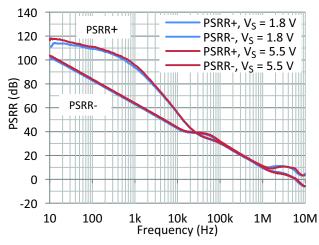


Figure 18. PSRR vs. Frequency

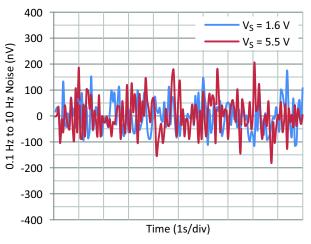


Figure 19. 0.1 Hz to 10 Hz Noise

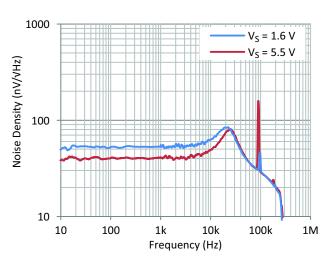


Figure 20. Voltage Noise Density vs. Frequency

TYPICAL CHARACTERISTICS

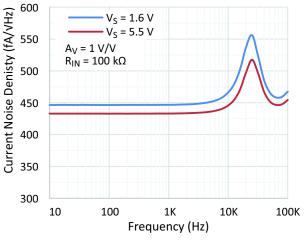


Figure 21. Current Noise Density vs. Frequency

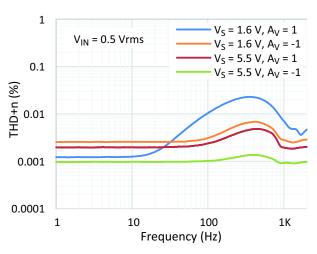


Figure 22. THD+n vs. Frequency

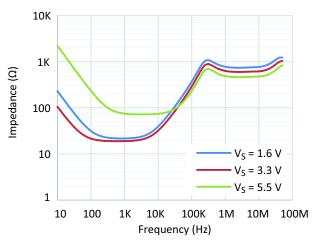


Figure 23. Open Loop Output Impedance vs. Frequency

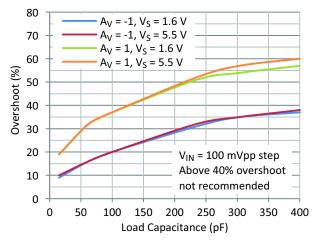


Figure 24. Small Signal Overshoot vs. Load Capacitance

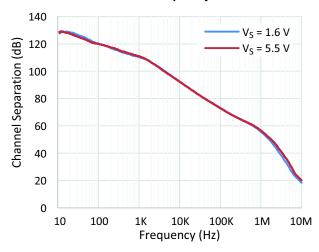


Figure 25. Channel Separation vs. Frequency

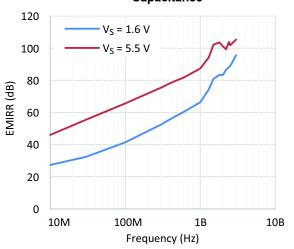
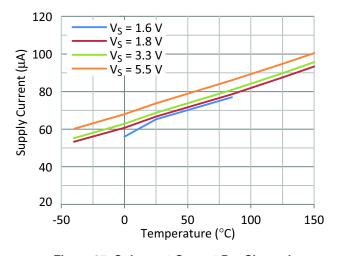


Figure 26. EMIRR vs. Frequency

TYPICAL CHARACTERISTICS



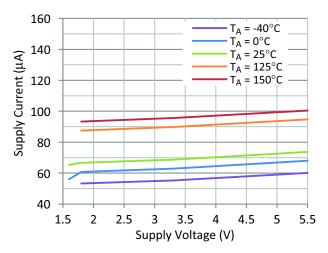
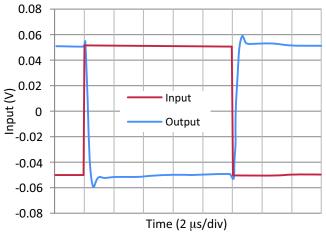


Figure 27. Quiescent Current Per Channel vs. Temperature

Figure 28. Quiescent Current Per Channel vs. Supply Voltage



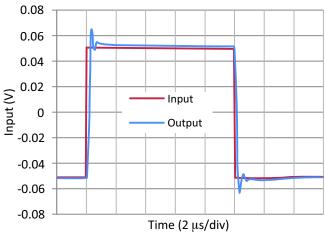
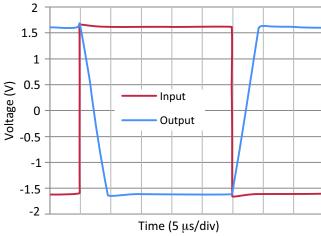


Figure 29. Inverting Small Signal Step Response with $V_S = 3.3 \text{ V}$ (Split Supplies)

Figure 30. Non-Inverting Small Signal Step Response with $V_S = 3.3 \text{ V}$ (Split Supplies)



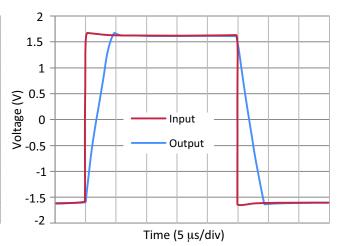


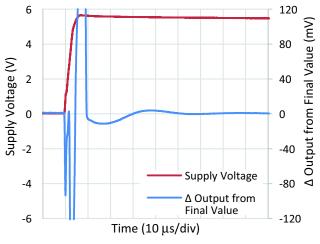
Figure 31. Inverting Large Signal Step Response with $V_S = 3.3 \text{ V}$ (Split Supply)

Figure 32. Non-Inverting Large Signal Step Response with V_S =3.3 V (Split Supply)

TYPICAL CHARACTERISTICS

Typical Performance at $T_A = 25^{\circ}C$, $V_{CM} = mid$ -supply, $C_L = 20$ pF, $R_L = 10$ k Ω to mid-supply, unless otherwise noted

2

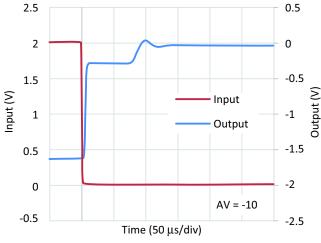


Δ Output from Final Value (mV) 1.5 30 20 1 Supply Voltage (V) 10 0.5 0 0 -0.5 -10 -20 -1 Supply Voltage -1.5 -30 Δ Output from Final Value -2 -40 Time (10 µs/div)

40

Figure 33. Power Up Time with 5.5 V Supply

Figure 34. Power Up Time with 1.6 V Supply



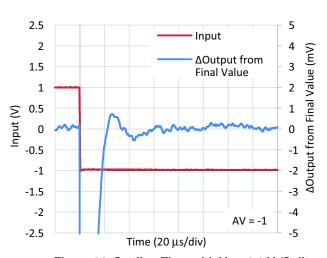


Figure 35. Output Overload Recovery with V_S = 3.3 V (Split Supply)

Figure 36. Settling Time with $V_S = 3.3 \text{ V}$ (Split Supply)

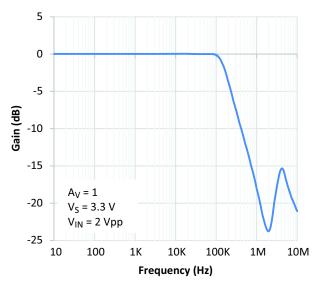


Figure 37. Large Signal Gain vs. Frequency

APPLICATIONS INFORMATION

The NCS21801, NCS21802, NCS21803, and NCS21804 precision amplifiers feature low input offset voltage and zero-drift over temperature. The input common mode voltage range extends 100 mV beyond the rails, allowing for measurements at ground or the supply voltage. These characteristics make the NCS21801 series well-suited for applications such as current sensing and sensor interface. The NCS21803 additionally features an enable pin that allows the amplifier to enter shutdown mode to reduce current consumption in low power applications.

Architecture

The low input offset voltage and zero-drift characteristics of amplifiers in the NCS21801 series is achieved through the chopper-stabilized architecture. Unlike the classical chopper architecture, the chopper-stabilized architecture has two signal paths to take advantage of both precision and speed.

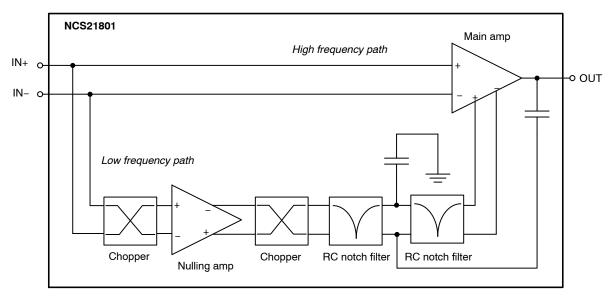


Figure 38. Simplified Schematic of the Chopper-stabilized Amplifier Architecture

In Figure 38, the lower signal path is where the chopper samples the input offset voltage, which is then used to correct the offset at the output. The offset correction occurs at a frequency of 100 kHz. Due to this periodic sampling, the chopper-stabilized architecture is optimized for best performance at frequencies up to the related Nyquist frequency (1/2 of the offset correction frequency). As the signal frequency exceeds the Nyquist frequency, 50 kHz, aliasing may occur at the output. This is an inherent limitation of all chopper and chopper-stabilized architectures. Nevertheless, the NCS2180x is designed to minimize aliasing beyond the Nyquist frequency. ON Semiconductor's patented approach utilizes two cascaded, symmetrical, RC notch filters tuned to the chopper frequency and its fifth harmonic to reduce aliasing effects.

The feed-forward path, which is shown as the upper signal path of the block diagram in Figure 38, is the high speed signal path that extends the gain bandwidth to 1.5 MHz. Not only does this help retain high frequency components of the input signal, but it also improves the loop gain at low frequencies. This is especially useful for low-side current sensing and sensor interface applications

where the signal is low frequency and the differential voltage is relatively small.

Both internal amplifiers have specialized circuitry to maintain nearly constant bandwidth, noise, and slew rate over the entire common mode voltage range. This also improves the overall input offset voltage, PSRR, and CMRR performance, while significantly reducing the THD+noise level. These characteristics are very useful in signal processing.

Input Offset Voltage

Input offset voltage is an intrinsic op amp characteristic that arises from mismatches in the IN+ and IN- paths. Since the NCS2180x series amplifiers have such low input offset voltage to begin with, external factors can have a non-trivial contribution to the effective input offset voltage. Conditions created by the physical environment can create package stress, thereby influencing the input offset voltage. These factors include air flow and PCB construction. Taking these factors into consideration, the input offset voltage performance should be validated in the application environment.

EMIRR

The NCS21801 series has built—in input filters to reduce high frequency EMI frequency signals before they enter the amplifier. Under normal circumstances, P–N junctions within the silicon can rectify these high frequency signals, and the effect can be seen as a DC offset at the output. Since this added offset can have a noticeable effect on high precision measurements, EMI rejection ratio (EMIRR) can be used to quantify the robustness of an amplifier to these signals.

Enable Function

The enable pin on NCS21803 allows the user to put the amplifier into shutdown mode when it is not is use. Setting EN to the logic low level reduces the current consumption down to less than 300 nA, which is useful for portable and

battery-powered applications. The output becomes high impedance. Setting the EN pin to logic high enables the output again, with the output reaching the final value ($\pm 1\%$) according the specified enable time. A floating EN pin results in an indeterminate output state.

Layout Recommendations

Bypass capacitors of $0.1 \mu F$ to ground should be placed as close as possible to the supply pins.

The UDFN8 package has an exposed leadframe die pad on the underside of the package. This pad should be soldered to the PCB, as shown in the recommended soldering footprint in the Package Dimensions section of this datasheet. The center pad can be electrically connected to VSS or it may be left floating. When connected to VSS, the center pad acts as a heat sink, improving the thermal resistance of the part.



SC-88A (SC-70-5/SOT-353) CASE 419A-02 **ISSUE L**

DATE 17 JAN 2013



- TES:
 DIMENSIONING AND TOLERANCING
 PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.
 419A-01 OBSOLETE. NEW STANDARD 3.
- 419A-02.
 DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.071	0.087	1.80	2.20	
В	0.045	0.053	1.15	1.35	
C	0.031	0.043	0.80	1.10	
D	0.004	0.012	0.10	0.30	
G	0.026	BSC	0.65 BSC		
Н		0.004		0.10	
J	0.004	0.010	0.10	0.25	
K	0.004	0.012	0.10	0.30	
N	0.008 REF		0.20	REF	
S	0.079	0.087	2.00	2.20	

GENERIC MARKING DIAGRAM*



XXX = Specific Device Code

= Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



0.50 0.0197 0.65 0.025 0.65 0.025 0.40 0.0157 1.9 mm 0.0748 SCALE 20:1

SOLDER FOOTPRINT

STYLE 1: PIN 1. BASE 2. EMITTER 3. BASE 4. COLLECTOR 5. COLLECTOR	STYLE 2: PIN 1. ANODE 2. EMITTER 3. BASE 4. COLLECTOR 5. CATHODE	STYLE 3: PIN 1. ANODE 1 2. N/C 3. ANODE 2 4. CATHODE 2 5. CATHODE 1	STYLE 4: PIN 1. SOURCE 1 2. DRAIN 1/2 3. SOURCE 1 4. GATE 1 5. GATE 2	STYLE 5: PIN 1. CATHODE 2. COMMON ANODE 3. CATHODE 2 4. CATHODE 3 5. CATHODE 4

5. COLLECTOR	5. CATHODE	5. CATHODE I	5. GATE 2	5. CATHODE 4
STYLE 6: PIN 1. EMITTER 2 2. BASE 2 3. EMITTER 1 4. COLLECTOR 5. COLLECTOR 2/BASE 1	STYLE 7: PIN 1. BASE 2. EMITTER 3. BASE 4. COLLECTOR 5. COLLECTOR	STYLE 8: PIN 1. CATHODE 2. COLLECTOR 3. N/C 4. BASE 5. EMITTER	STYLE 9: PIN 1. ANODE 2. CATHODE 3. ANODE 4. ANODE 5. ANODE	Note: Please refer to datasheet for style callout. If style type is not called out in the datasheet refer to the device datasheet pinout or pin assignment.

DOCUMENT NUMBER:	98ASB42984B	Electronic versions are uncontrolled except when accessed directly from the Document Re Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	SC-88A (SC-70-5/SOT-35	63)	PAGE 1 OF 1

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

SC-88/SC70-6/SOT-363 CASE 419B-02 **ISSUE Y**

DATE 11 DEC 2012





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS
- CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH,
- DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.20 PER END. DIMENSIONS D AND E1 AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY AND DATUM H. DATUMS A AND B ARE DETERMINED AT DATUM H. DIMENSIONS b AND c APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.08 AND 0.15 FROM THE TIP.

- DIMENSION & DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 TOTAL IN EXCESS OF DIMENSION 6 AT MAXIMUM MATERIAL CONDITION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE FOOT.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α			1.10			0.043
A1	0.00		0.10	0.000		0.004
A2	0.70	0.90	1.00	0.027	0.035	0.039
b	0.15	0.20	0.25	0.006	0.008	0.010
С	0.08	0.15	0.22	0.003	0.006	0.009
D	1.80	2.00	2.20	0.070	0.078	0.086
E	2.00	2.10	2.20	0.078	0.082	0.086
E1	1.15	1.25	1.35	0.045	0.049	0.053
е		0.65 BS	С	0.026 BSC		
L	0.26	0.36	0.46	0.010	0.014	0.018
L2		0.15 BS	C		0.006 BS	SC
aaa	0.15 0.30 0.10			0.006		
bbb					0.012	
ccc					0.004	
ddd		0.10			0.004	

RECOMMENDED SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXX = Specific Device Code

= Date Code* = Pb-Free Package

(Note: Microdot may be in either location)

- *Date Code orientation and/or position may vary depending upon manufacturing location.
- *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

STYLES ON PAGE 2

DOCUMEN	NT NUMBER:	98ASB42985B	Electronic versions are uncontrolled except when accessed directly from the Docum- Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in re-	
DE	SCRIPTION:	SC-88/SC70-6/SOT-363		PAGE 1 OF 2

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

SC-88/SC70-6/SOT-363 CASE 419B-02 ISSUE Y

DATE 11 DEC 2012

STYLE 1: PIN 1. EMITTER 2 2. BASE 2 3. COLLECTOR 1 4. EMITTER 1 5. BASE 1 6. COLLECTOR 2	STYLE 2: CANCELLED	STYLE 3: CANCELLED	STYLE 4: PIN 1. CATHODE 2. CATHODE 3. COLLECTOR 4. EMITTER 5. BASE 6. ANODE	STYLE 5: PIN 1. ANODE 2. ANODE 3. COLLECTOR 4. EMITTER 5. BASE 6. CATHODE	STYLE 6: PIN 1. ANODE 2 2. N/C 3. CATHODE 1 4. ANODE 1 5. N/C 6. CATHODE 2
STYLE 7: PIN 1. SOURCE 2 2. DRAIN 2 3. GATE 1 4. SOURCE 1 5. DRAIN 1 6. GATE 2	STYLE 8: CANCELLED	STYLE 9: PIN 1. EMITTER 2 2. EMITTER 1 3. COLLECTOR 1 4. BASE 1 5. BASE 2 6. COLLECTOR 2	STYLE 10: PIN 1. SOURCE 2 2. SOURCE 1 3. GATE 1 4. DRAIN 1 5. DRAIN 2 6. GATE 2	STYLE 11: PIN 1. CATHODE 2 2. CATHODE 2 3. ANODE 1 4. CATHODE 1 5. CATHODE 1 6. ANODE 2	STYLE 12: PIN 1. ANODE 2 2. ANODE 2 3. CATHODE 1 4. ANODE 1 5. ANODE 1 6. CATHODE 2
STYLE 13: PIN 1. ANODE 2. N/C 3. COLLECTOR 4. EMITTER 5. BASE 6. CATHODE	STYLE 14: PIN 1. VREF 2. GND 3. GND 4. IOUT 5. VEN 6. VCC	STYLE 15: PIN 1. ANODE 1 2. ANODE 2 3. ANODE 3 4. CATHODE 3 5. CATHODE 2 6. CATHODE 1	STYLE 16: PIN 1. BASE 1 2. EMITTER 2 3. COLLECTOR 2 4. BASE 2 5. EMITTER 1 6. COLLECTOR 1	STYLE 17: PIN 1. BASE 1 2. EMITTER 1 3. COLLECTOR 2 4. BASE 2 5. EMITTER 2 6. COLLECTOR 1	STYLE 18: PIN 1. VIN1 2. VCC 3. VOUT2 4. VIN2 5. GND 6. VOUT1
STYLE 19: PIN 1. I OUT 2. GND 3. GND 4. V CC 5. V EN 6. V REF	STYLE 20: PIN 1. COLLECTOR 2. COLLECTOR 3. BASE 4. EMITTER 5. COLLECTOR 6. COLLECTOR	STYLE 21: PIN 1. ANODE 1 2. N/C 3. ANODE 2 4. CATHODE 2 5. N/C 6. CATHODE 1	STYLE 22: PIN 1. D1 (i) 2. GND 3. D2 (i) 4. D2 (c) 5. VBUS 6. D1 (c)	STYLE 23: PIN 1. Vn 2. CH1 3. Vp 4. N/C 5. CH2 6. N/C	STYLE 24: PIN 1. CATHODE 2. ANODE 3. CATHODE 4. CATHODE 5. CATHODE 6. CATHODE
STYLE 25: PIN 1. BASE 1 2. CATHODE 3. COLLECTOR 2 4. BASE 2 5. EMITTER 6. COLLECTOR 1	STYLE 26: PIN 1. SOURCE 1 2. GATE 1 3. DRAIN 2 4. SOURCE 2 5. GATE 2 6. DRAIN 1	STYLE 27: PIN 1. BASE 2 2. BASE 1 3. COLLECTOR 1 4. EMITTER 1 5. EMITTER 2 6. COLLECTOR 2	STYLE 28: PIN 1. DRAIN 2. DRAIN 3. GATE 4. SOURCE 5. DRAIN 6. DRAIN	STYLE 29: PIN 1. ANODE 2. ANODE 3. COLLECTOR 4. EMITTER 5. BASE/ANODE 6. CATHODE	STYLE 30: PIN 1. SOURCE 1 2. DRAIN 2 3. DRAIN 2 4. SOURCE 2 5. GATE 1 6. DRAIN 1

Note: Please refer to datasheet for style callout. If style type is not called out in the datasheet refer to the device datasheet pinout or pin assignment.

DOCUMENT NUMBER:	98ASB42985B	Electronic versions are uncontrolled except when accessed directly from the Document Reposit Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	SC-88/SC70-6/SOT-363		PAGE 2 OF 2

ON Semiconductor and III are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.



TSOP-5 **CASE 483 ISSUE N**

DATE 12 AUG 2020









NOTES:

- DIMENSIONING AND TOLERANCING PER ASME
- CONTROLLING DIMENSION: MILLIMETERS.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH
 THICKNESS. MINIMUM LEAD THICKNESS IS THE
 MINIMUM THICKNESS OF BASE MATERIAL.
- DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSION A. OPTIONAL CONSTRUCTION: AN ADDITIONAL
- TRIMMED LEAD IS ALLOWED IN THIS LOCATION. TRIMMED LEAD NOT TO EXTEND MORE THAN 0.2 FROM BODY.

	MILLIMETERS			
DIM	MIN	MAX		
Α	2.85	3.15		
В	1.35	1.65		
C	0.90	1.10		
D	0.25	0.50		
G	0.95 BSC			
Н	0.01	0.10		
J	0.10	0.26		
K	0.20	0.60		
М	0 °	10 °		
S	2 50	3.00		

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*





XXX = Specific Device Code XXX = Specific Device Code

= Assembly Location = Date Code = Year = Pb-Free Package

= Work Week W

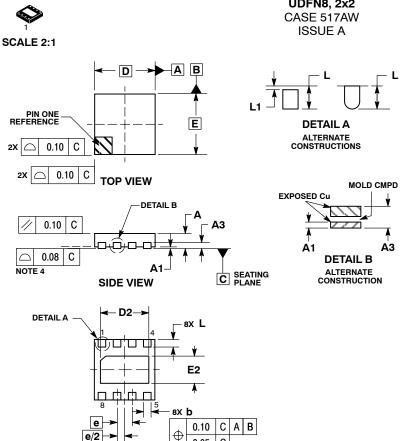
= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

DOCUMENT NUMBER:	98ARB18753C	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	
DESCRIPTION:	TSOP-5		PAGE 1 OF 1

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.



0.05 C NOTE 3

UDFN8, 2x2

DATE 13 NOV 2015

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION 6 APPLIES TO PLATED TERMI-NALS AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM THE TERMINAL TIP.
- AND 0.30 MM FHOM THE TEHMINAL TIP.
 COPLANARITY APPLIES TO THE EXPOSED
 PAD AS WELL AS THE TERMINALS.
 FOR DEVICE OPN CONTAINING W OPTION,
 DETAIL B ALTERNATE CONSTRUCTION IS
 NOT APPLICABLE.

	MILLIMETERS				
DIM	MIN MAX				
Α	0.45	0.55			
A1	0.00	0.05			
A3	0.13	REF			
b	0.18	0.30			
D	2.00 BSC				
D2	1.50	1.70			
E	2.00	BSC			
E2	0.80	1.00			
е	0.50 BSC				
L	0.20	0.45			
L1		0.15			

GENERIC MARKING DIAGRAM*



XX = Specific Device Code

= Date Code

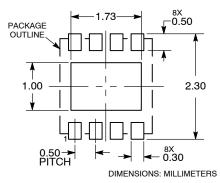
= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present.

RECOMMENDED **SOLDERING FOOTPRINT***

BOTTOM VIEW



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON34462E	Electronic versions are uncontrolled except when accessed directly from the Document Reposito Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	UDFN8, 2X2		PAGE 1 OF 1

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.



Micro8 CASE 846A-02 ISSUE K

DATE 16 JUL 2020









NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION 6 DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.10 mm IN EXCESS OF MAXIMUM MATERIAL CONDITION.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 mm PER SIDE. DIMENSION E DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 mm PER SIDE. DIMENSIONS D AND E ARE DETERMINED AT DATUM F.
- DATUMS A AND B ARE TO BE DETERMINED AT DATUM F.
- A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



MOUNTING FOOTPRINT

DIM	MI	LLIMETE	RS
ויונע	MIN.	N□M.	MAX.
Α	-	-	1.10
A1	0.05	0.08	0.15
b	0.25	0.33	0.40
c	0.13	0.18	0.23
D	2.90	3.00	3.10
E	2.90	3.00	3.10
е	0.65 BSC		
HE	4.75	4.90	5.05
L	0.40	0.55	0.70

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code Α = Assembly Location

Υ = Year W = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

STYLE 1:	STYLE 2:	STYLE 3:
PIN 1. SOURCE	PIN 1. SOURCE 1	PIN 1. N-SOURCE
SOURCE	2. GATE 1	2. N-GATE
SOURCE	3. SOURCE 2	P-SOURCE
GATE	4. GATE 2	4. P-GATE
DRAIN	5. DRAIN 2	5. P-DRAIN
DRAIN	6. DRAIN 2	6. P-DRAIN
7. DRAIN	7. DRAIN 1	7. N-DRAIN
8. DRAIN	8. DRAIN 1	8. N-DRAIN

DOCUMENT NUMBER:	98ASB14087C	Electronic versions are uncontrolled except when accessed directly from the Document Re Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	MICRO8		PAGE 1 OF 1

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.



DATE 17 FEB 2016

- NOTES.

 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

 2. CONTROLLING DIMENSION: MILLIMETER.

 3. DIMENSION A DOES NOT INCLUDE MOLD
- FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
 DIMENSION B DOES NOT INCLUDE
- INTERLEAD FLASH OR PROTRUSION.
 INTERLEAD FLASH OR PROTRUSION SHALL
- INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.

 5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.

 6. TERMINAL NUMBERS ARE SHOWN FOR DEFERENCE ONLY.
- REFERENCE ONLY.
 DIMENSION A AND B ARE TO BE
- DETERMINED AT DATUM PLANE -W-.

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
Α	4.90	5.10	0.193	0.200
В	4.30	4.50	0.169	0.177
С		1.20		0.047
D	0.05	0.15	0.002	0.006
F	0.50	0.75	0.020	0.030
G	0.65 BSC		0.026 BSC	
Н	0.50	0.60	0.020	0.024
J	0.09	0.20	0.004	0.008
J1	0.09	0.16	0.004	0.006
K	0.19	0.30	0.007	0.012
K1	0.19	0.25	0.007	0.010
L	6.40 BSC		0.252 BSC	
М	0°	8 °	0 °	8 °

GENERIC MARKING DIAGRAM*



= Assembly Location

= Wafer Lot ٧ = Year

W = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

◀	7.06
1	
	
	0.65
, <u> </u>	— — — • • • • • • • • • • • • • • • • • • •
14X	─
0.36 14X 1.26	DIMENSIONS: MILLIMETERS

SOLDERING FOOTPRINT

DOCUMENT NUMBER:	98ASH70246A	Electronic versions are uncontrolled except when accessed directly from the Document Repository Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	TSSOP-14 WB		PAGE 1 OF 1	

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

ON Semiconductor and the are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor and see no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

ON Semiconductor Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative